

IDM29803 16-Way Branch Controller

General Description

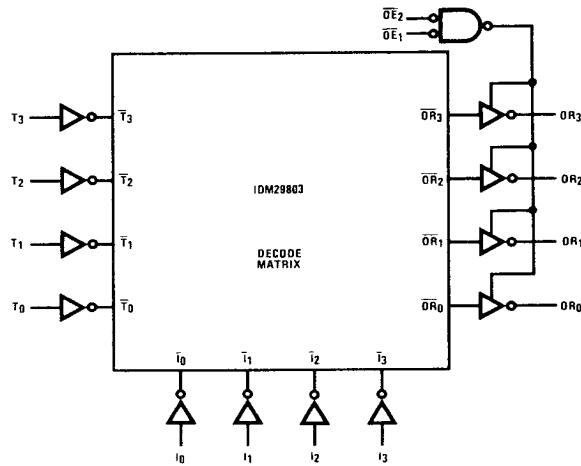
When used in conjunction with the IDM2909A address controller, the IDM29803 provides 16-way branch control. Four different inputs can be tested simultaneously by the 16 instructions of the IDM29803; thus, the four OR inputs of the IDM2909A can be driven by the four outputs of the IDM29803 and a branch can be made to any one of the 16 addresses.

If one test (T) input is being tested, the device will select one of two possible addresses; if two inputs are being tested, the device will select one of four possible addresses and, if three inputs are being tested, one of eight addresses will be selected. If all four inputs are tested, one of sixteen addresses is selected as the field used to drive the OR inputs of the IDM2909A. The "zero" instruction serves as a test inhibit function.

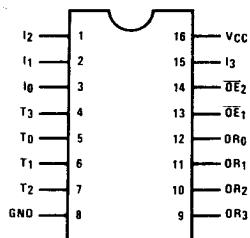
Features and Benefits

- 16 separate instructions — 2-, 4-, 8-, or 16-way branch in one microprogram execution cycle
- Four discrete test inputs
- Four discrete outputs for driving the four OR inputs of the IDM2909A address controller
- Provides a maximum branching capability in a microprogram control unit using the IDM2909A
- Uses low-power Schottky technology
- Meets all requirements of MIL-STD-883

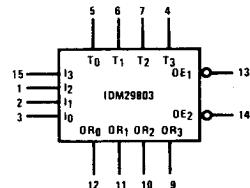
Logic Diagram



Connection Diagram



Logic Symbol



Absolute Maximum Ratings (Note 1)**Operating Range**

		P/N	Ambient Temperature	VCC
Storage Temperature	-65°C to +125°C			
Temperature (Ambient) Under Bias	-55°C to +125°C			
Supply Voltage to Ground Potential	-0.5V to +7.0V			
DC Voltage Applied to Outputs for High Output State	-0.5V to +VCC max	Com'l IDM29803DC, NC	0°C to +70°C	4.75V to 5.25V
DC Input Voltage	-0.5V to +5.5V	Mil IDM29803DM, DM/883	-55°C to +125°C	4.50V to 5.50V
DC Output Current, into Outputs	30 mA			
DC Input Current	-30 mA to +5.0 mA			

DC Electrical Characteristics (Note 2)

PARAMETER	CONDITIONS	Com'l			Mil			UNITS
		MIN	TYP	MAX	MIN	TYP	MAX	
I _F	Input Load Current, All Inputs	V _{CC} = Max., V _F = 0.45V		-80	-250		-80	-250 μA
I _R	Input Leakage Current, All Inputs	V _{CC} = Max., V _R = 2.7V			25		25	μA
I _{RB}	Input Leakage Current, All Inputs	V _{CC} = Max., V _{RB} = 5.5V			1.0		1.0	mA
V _{OOL}	Low Level Output Voltage	V _{CC} = Min., I _{OOL} = 16 mA		0.35	0.45		0.35	0.5 V
V _{UIL}	Low Level Input Voltage				0.80		0.80	V
V _{UH}	High Level Input Voltage			2.0		2.0		V
I _{CEx}	Output Leakage Current (Open-Collector Only)	V _{CC} = Max., V _{CEx} = 2.4V			50		50	μA
		V _{CC} = Max., V _{CEx} = 5.5V			100		100	μA
V _C	Input Clamp Voltage	V _{CC} = Min., I _{IN} = -18 mA		-0.8	-1.2		-0.8	-1.2 V
C _{IN}	Input Capacitance	V _{CC} = 5V, V _{IN} = 2V, T _A = 25°C, 1 MHz		4.0		4.0		pF
C _O	Output Capacitance	V _{CC} = 5V, V _O = 2V, T _A = 25°C, 1 MHz, Output "OFF"		6.0		6.0		pF
I _{CC}	Power Supply Current	V _{CC} = Max., All Inputs Grounded, All Outputs Open		80	130		80	130 mA
TRI-STATE PARAMETERS								
I _{SC}	Output Short Circuit Current	V _O = 0V, V _{CC} = Max. (Note 3)	-30	-60	-100	-30	-60	-100 mA
I _{HZ}	Output Leakage (TRI-STATE)	V _{CC} = Max., V _O = 0.45 to 2.4V, Chip Disabled			+50		+50	μA
V _{OH}	Output Voltage High	I _{OH} = -2 mA				2.4	3.2	
		I _{OH} = -6.5 mA	2.4	3.2				V

AC Electrical Characteristics (With standard load)

PARAMETER	CONDITIONS	Com'l			Mil			UNITS
		MIN	TYP	MAX	MIN	TYP	MAX	
t _{AA}	(Figure 1)	10	35	50	10	35	60	ns
t _{EA}	(Figure 2)	5	15	25	5	15	30	ns
t _{ER}	(Figure 2)	5	15	25	5	15	30	ns

Note 1: Absolute maximum ratings are those values beyond which the device may be permanently damaged. They do not mean that the device may be operated at these values.

Note 2: These limits apply over the entire operating range unless stated otherwise. All typical values are for V_{CC} = 5V and T_A = 25°C.

Note 3: During I_{SC} measurement, only one output at a time should be grounded. Permanent damage may otherwise result.

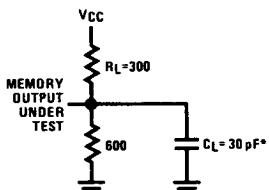
Switching Characteristics Over Operating Range

Symbol	Description	Test Conditions	Com'l		Mil		Units
			Min	Max	Min	Max	
tPLH	I _i to OR _i	$C_L = 15 \text{ pF}$ $R_L = 2.0 \text{ k}\Omega$		50		60	ns
tPHL	T _i to OR _i			50		60	ns
tPLH	OE _i to OR _i			25		30	ns
tPHL	OE _i to OR _i			25		30	ns
tZH							
tZL							
tHZ							
tLZ							

Definition of Functional Terms

- I₀, I₁, I₂, I₃ The four instruction inputs to the device
 T₀, T₁, T₂, T₃ The four test inputs for the device
 OR₀, OR₁, OR₂, OR₃ The four outputs of the device that are connected to the four OR inputs of the IDM2909A
 OE₁, OE₂ Output Enable. When either OE input is High, the OR_i outputs are in the high impedance state. When both the OE₁ and OE₂ inputs are Low, the OR outputs are enabled and the selected data will be present.

Standard Test Load



*CL includes probe and jig capacitance

- Input waveforms are supplied by a pulse generator having the following characteristics: PRR = 1 MHz, Z_{OUT} = 50 Ω, t_r ≤ 2.5 ns and t_f ≤ 2.5 ns (between 1.0V and 2.0V).
- t_{AA} is measured with both enable inputs at a steady low level.
- t_{EA} and t_{ER} are measured from the 1.5V on inputs and outputs with all address inputs at a steady level and with the unused enable input at a steady low level.

Switching Time Waveforms

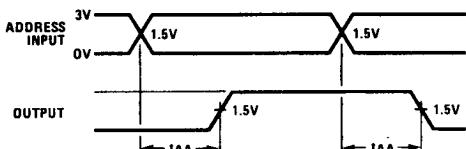


Figure 1. Address Access Time

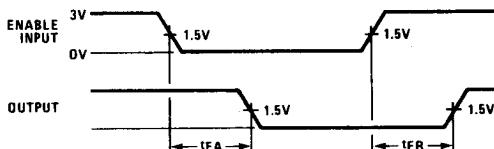


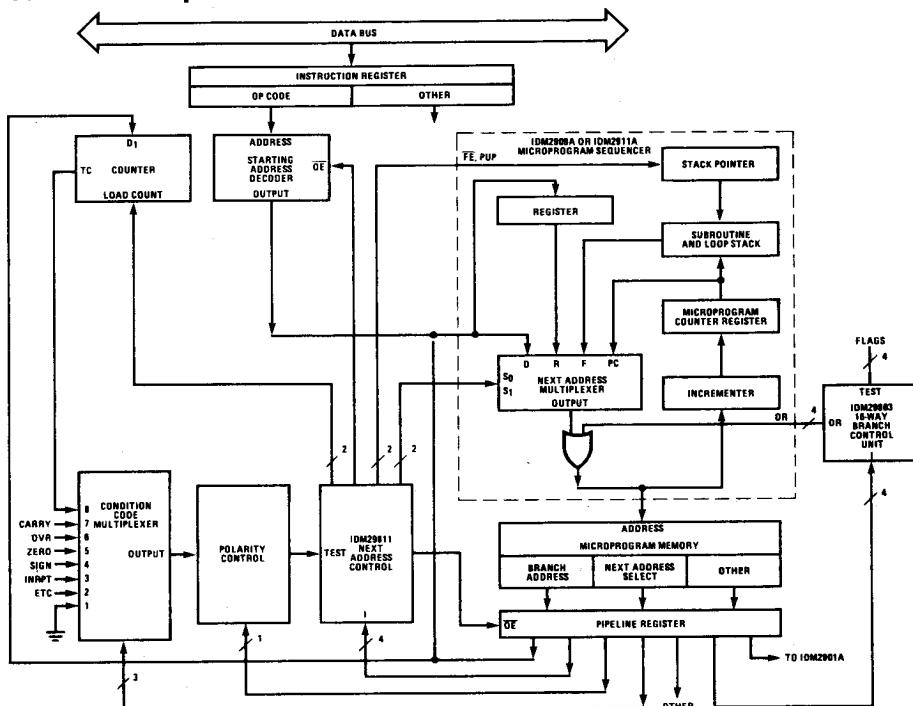
Figure 2. Enable Access Time and Recovery Time

Guaranteed Loading Rules Over Operating Range (In Unit Loads)

A Low-Power Schottky TTL Unit Load is defined as 20 μ A measured at 2.7V High and -0.36 mA measured at 0.4V Low.

Pin Nos.	Input/Output	Input Load	Output High	Output Low
1	I ₂	0.5	—	—
2	I ₁	0.5	—	—
3	I ₀	0.5	—	—
4	T ₃	0.5	—	—
5	T ₀	0.5	—	—
6	T ₁	0.5	—	—
7	T ₂	0.5	—	—
8	GND	—	—	—
9	OR ₃	—	100	44
10	OR ₂	—	100	44
11	OR ₁	—	100	44
12	OR ₀	—	100	44
13	OE ₁	0.5	—	—
14	OE ₂	0.5	—	—
15	I ₃	0.5	—	—
16	V _{CC}	—	—	—

Applications Example



Note: The least significant microprogram sequencer is an IDM2909A and the more significant sequencers are IDM2911A's.

A Typical Computer Control Unit Using the IDM2909A, IDM2911A, IDM29803 and IDM29811.

Function Table

Function	I ₃	I ₂	I ₁	I ₀	T ₃	T ₂	T ₁	T ₀	OR ₃	OR ₂	OR ₁	OR ₀
No Test	L	L	L	L	X	X	X	X	L	L	L	L
Test T ₀	L	L	L	H	X	X	X	L	L	L	L	H
Test T ₁	L	L	H	L	X	X	L	X	L	L	L	L
Test T ₀ & T ₁	L	L	H	H	X	X	L	H	L	L	L	H
Test T ₂	L	H	L	L	X	L	X	X	L	L	L	H
Test T ₀ & T ₂	L	H	L	H	X	L	X	L	L	L	L	H
Test T ₁ & T ₂	L	H	H	L	X	L	L	X	L	L	L	H
Test T ₀ , T ₁ , & T ₂	L	H	H	H	X	L	L	L	L	L	L	H
Test T ₃	H	L	L	L	L	X	X	X	L	L	L	H
Test T ₀ & T ₃	H	L	L	H	L	X	X	L	L	L	H	H
Test T ₁ & T ₃	H	L	H	L	L	X	L	X	L	L	L	H
Test T ₀ , T ₁ , & T ₃	H	L	H	H	L	X	L	H	L	L	H	H
Test T ₂ & T ₃	H	H	L	L	L	H	X	X	L	L	L	H
Test T ₀ , T ₂ , & T ₃	H	H	L	H	L	L	X	L	L	L	H	H
Test T ₁ , T ₂ , & T ₃	H	H	H	L	L	L	H	X	L	L	H	H
Test T ₀ , T ₁ , T ₂ , & T ₃	H	H	H	H	L	L	L	L	L	L	H	H

Ordering Information

Package Type	Package Number	Temperature Range	Order Number
Molded DIP	N16A	0°C to +70°C	IDM29803NC
Hermetic DIP	J16A (D16C)	0°C to +70°C	IDM29803JC
Hermetic DIP	J16A (D16C)	-55°C to +125°C	IDM29803JM
Hermetic DIP	J16A (D16C)	-55°C to +70°C	IDM29803JM/883